



HOMMEL TESTER T1000 – Technical specifications

HOMMEL TESTER T1000	basic	top	wave
Display	Rear-illuminated graphic display 240 x 160 dots		
Power source	Ni-Metallhydrid-Battery, Rechargeable 24V/2,5 A, automatic select 90-240 V		
Battery capacity	approx. 500 measurements		
Operating temperature	0-50°C, max. 85% relative humidity		
Interfaces	V24, RS232		
Data storage	200 profiles, 999 measurements		
Measurement programmes	5 measurement programmes		
PCMCIA drive	-	integrated	Optional
Compact Flash Memory Card	-	integrated (32 MB)	Optional (32 MB)
Dimensions W x D x H	253 x 193 x 80 mm		
Weight	1,600 g		
Measurement type	Skid measurement		Skid/skidless measurement
Total deviation as per DIN 4772	Class 1		
Measurement ranges/resolution	+/- 80 µm / 0.01 µm; +/- 320 µm / 0.04 µm		
Instrument set-up	automatic or manual		
Filter			
ISO 11562, Part 1 (50% Gauss)	Gauss (M1) digital filter (mm); 0.025 / 0.08 / 0.25 / 0.8 / 2.5 / 8 – selectable in 1 Cut-off stages		
ISO 13565-1	M2 (Rk parameter) Polynomfit		
Traverse length lt (mm)	0.48 / 1.5 / 4.8 / 15; max. 16	0.48 / 1.5 / 4.8 / 15; max. 20	
ISO 4288/12085 (Motif)	variable 0.48 – 16 mm	variable 0.05 - 20 mm	
Sampling length ln ISO 4287	1.25 / 4.0 / 12.5		
Individual traverse length lr, lw, lp ISO 4287	1 – 5 selectable		
Traverse speed (mm/s)	0.15 / 0.5 / 1.0	0.1 / 0.15 / 0.5 / 1.0; variable 0.05 – 3.0	
Cut-off λ (mm)	0.08 / 0.25 / 0.8 / 2.5 / 8.0		
Bandpass filter Lc/Ls ISO 3274	100; 300		
Roughness parameters ISO 4287	Ra, Rz, Rmax, Rt, Rq, RPc, RSm, RMr(c), Rp, Rv, Rpm, R3z, Rz-ISO, Rsk, Rku, R8c, Rmr%, Rmrµm; Rdq		
Core roughness parameters ISO 13565	Rk, Rpk, Rvk, Mr1, Mr2, Rpk*, Rvk*, Vo		
Waviness parameters ISO 4287		Wa, Wz, Wmax, Wt, WPc, WSm, Wq, Wp, Wv, Wpm, Wsk, Wku, Wdq	
Profile parameters ISO 4287	Pa, Pz, Pmax, Pt, PPC, PSm, Pmr(c), Pp, Pv, Ppm, Psk, Pku, Pq, P8c, Pmr%, Pmrµm, Pdq		
Motif parameters ISO 4287	R, Rx, AR, P8c (CR, CL, CF), Nr, Nw	W, Wx, Wte, AW	
Roughness parameters JIS B0601	Rz-JIS		
Statistic	999 measurements: Range, Xcross, Max., Min., Standard deviation		
Languages	German, English, French, Spanish, Italian, Czech, Polish, Swedish		
Measuring system	µm / µinch selectable		
Tolerance limits upper/lower	adjustable for all parameters		
Integrated printer			
Vertical magnification	automatic up til max. 50,000-fold		
Horizontal magnification	10 / 20 / 40 / 50 / 100 / 200 / 400-fold traverse assigned		
Paper	Thermal paper 40-50 g/m² - 57,5 mm width, length 10 m		
Printing speed	30 mm/s		
Resolution	8 dots/mm		
Traverse unit			
Types of pick-up	LV16	waveline™ 20	
Traverse length	Skid pick-up	Skidless pick-up	
Pick-up direction	16 mm	20 mm	
Dimensions L x W x H	axial, perpendicular to axis traversing	axial	
Weight	134 x 45 x 47 mm	242 x 54 x 74 mm	
Working area	250 g	1,100 g	
Operating controls	over 360°		
	integrated start key		
Surface pick-up			
Measuring range	T1E	TKL 300L	
Diamond stylus tip	80 µm	600 µm	
Skid radius	5 µm; 90°	5 µm; 90° large diamond	
For holes from	lengthways 30 mm / transversal 1,9 mm	-	
Dimensions D/L	4 mm / depth 20 mm	4 mm / depth 33 mm	
Weight	D 10 mm / L 80 mm	D 13 mm / 85,1 mm	
	12 g	15 g	

Subject to change without notice. 04/2003

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